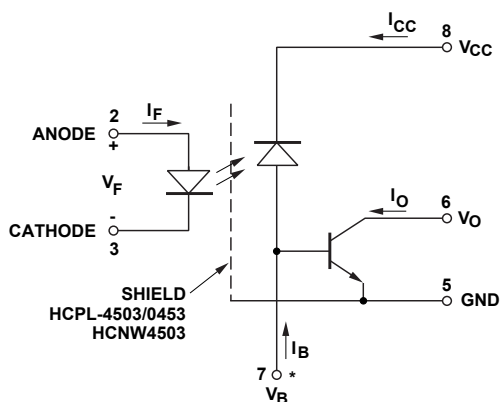


The HCPL-4502, HCPL-0452, and HCNW4502 provide the electrical and switching performance of the 6N136, HCPL-0501, and HCNW136 with increased ESD protection.

The HCPL-4503, HCPL-0453, and HCNW4503 are similar to the HCPL-4502, HCPL-0452, and HCNW4502 optocouplers but have increased common mode transient immunity of 15 kV/ μ s minimum at $V_{CM} = 1500$ V guaranteed.

Schematic



* NOTE: FOR HCPL-4502/-3, HCPL-0452/3, HCNW4502/3, PIN 7 IS NOT CONNECTED.

Selection Guide

Minimum CMR		8-Pin DIP (300 Mil)		Small-Outline SO-8		(400 Mil)		Widebody Hermetic
dV/dt (V/ μ s)	V_{CM} (V)	Current Transfer Ratio (%)	Single Channel Package	Dual Channel Package*	Single Channel Package	Dual Channel Package*	Single Channel Package	Single and Dual Channel Packages*
1,000	10	7	6N135	HCPL-2530	HCPL-0500	HCPL-0530	HCNW135	
		19	6N136 HCPL-4502†	HCPL-2531	HCPL-0501 HCPL-0452†	HCPL-0531	HCNW136 HCNW4502†	
		15	HCPL-2502					
15,000	1500	19	HCPL-4503†	HCPL-4534	HCPL-0453†	HCPL-0534	HCNW4503†	
1,000	10	9						HCPL-55XX HCPL-65XX 4N55

*Technical data for these products are on separate Avago publications.

†Pin 7, transistor base, is not connected.

Ordering Information

6N135, 6N136, HCPL-2502, HCPL-4502 and HCPL-4503, HCPL-0452, HCPL-0453, HCPL-0500, HCPL-0501 are UL Recognized with 3750 Vrms for 1 minute per UL1577.

HCNW135, HCNW136, HCNW4502 and HCNW4503 are UL Recognized with 5000 Vrms for 1 minute per UL1577. All devices above listed are approved under CSA Component Acceptance Notice #5, File CA 88324.

Part number	Option		Package	Surface Mount	Gull Wing	Tape & Reel	UL 5000 Vrms/ 1 Minute rating	IEC/EN/DIN EN 60747-5-2	Quantity
	RoHS Compliant	Non RoHS Compliant							
6N135 6N136 HCPL-2502 HCPL-4502 HCPL-4503	-000E	No option	300mil DIP-8						50 per tube
	-300E	#300		X	X				50 per tube
	-500E	#500		X	X	X			1000 per reel
	-020E	#020					X		50 per tube
	-320E	#320		X	X		X		50 per tube
	-520E	#520		X	X	X	X		1000 per reel
	-060E	#060						X	50 per tube
	-360E	#360		X	X			X	50 per tube
	-560E	#560		X	X	X		X	1000 per reel
HCPL-0452 HCPL-0453 HCPL-0500 HCPL-0501	-000E	No option	SO-8						100 per tube
	-500E	#500		X	X	X			1500 per reel
	-060E	#060						X	100 per tube
	-560E	#560		X	X	X		X	1500 per reel
HCNW135 HCNW136 HCNW4502 HCNW4503	-000E	No option	400mil Widebody DIP-8				X	X	42 per tube
	-300E	#300		X	X		X	X	42 per tube
	-500E	#500		X	X	X	X	X	750 per reel

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:

HCPL-4502-560E to order product of 300mil DIP Gull Wing Surface Mount package in Tape and Reel packaging with IEC/EN/DIN EN 60747-5-2 Safety Approval in RoHS compliant.

Example 2:

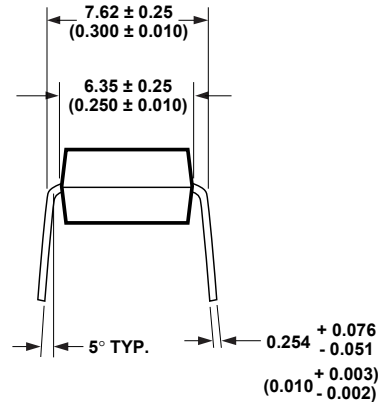
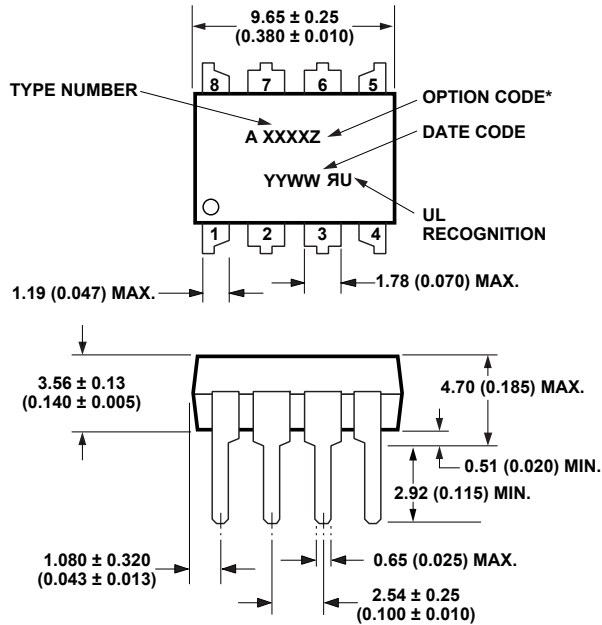
HCPL-4502 to order product of 300mil DIP package in tube packaging and non RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.

Remarks: The notation '#XXX' is used for existing products, while (new) products launched since 15th July 2001 and RoHS compliant option will use '-XXXE'.

Package Outline Drawings

8-Pin DIP Package (6N135/6, HCPL-4502/3, HCPL-2502)



DIMENSIONS IN MILLIMETERS AND (INCHES).

*MARKING CODE LETTER FOR OPTION NUMBERS

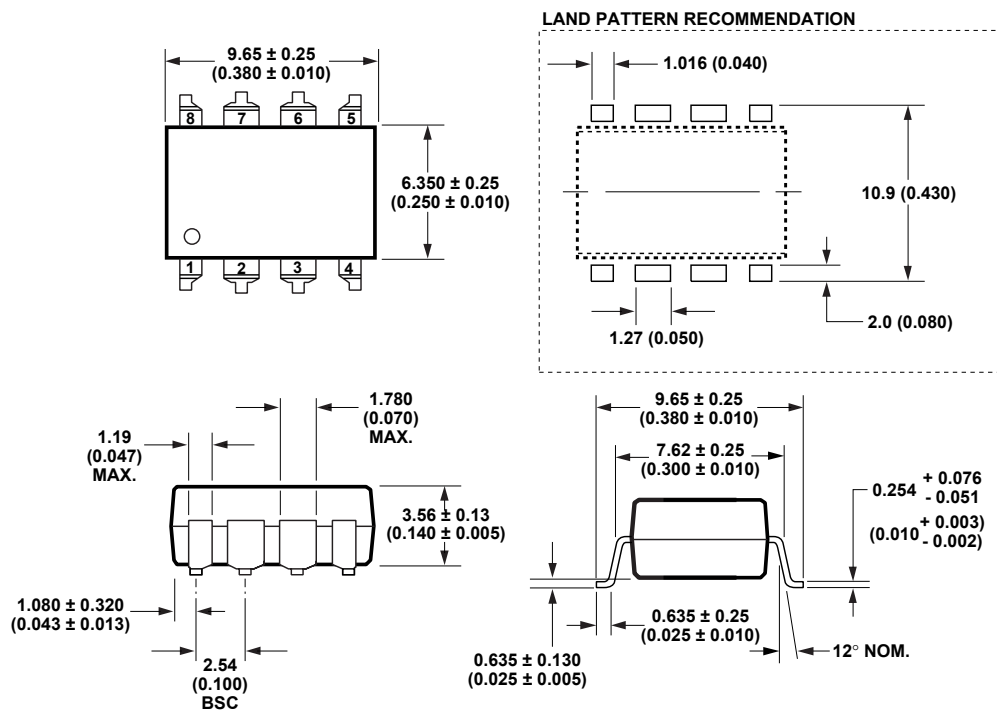
"L" = OPTION 020

"V" = OPTION 060

OPTION NUMBERS 300 AND 500 NOT MARKED.

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

8-Pin DIP Package with Gull Wing Surface Mount Option 300 (6N135/6, HCPL-4502/3)

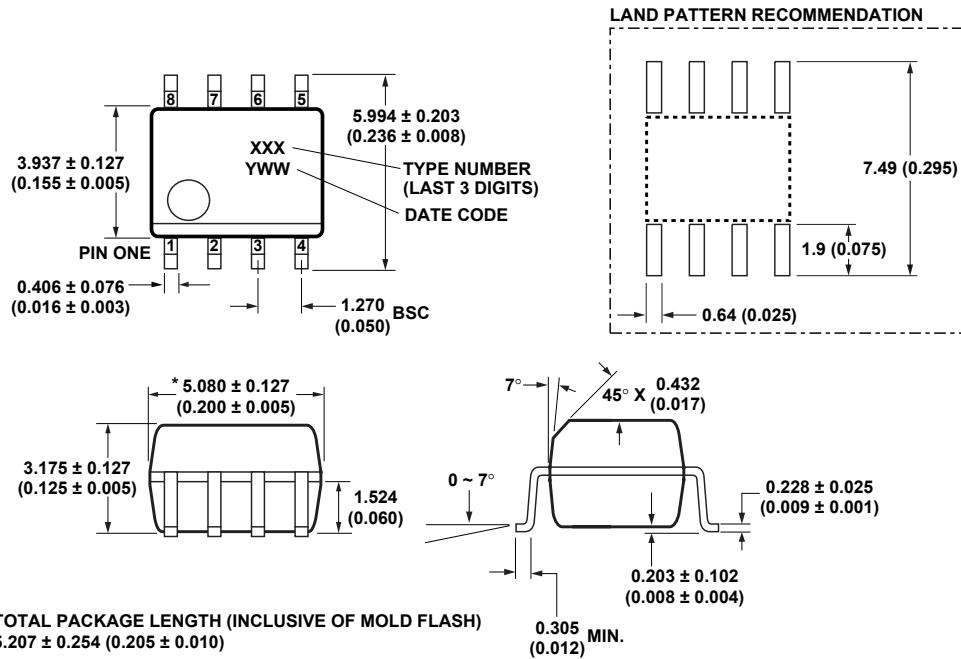


DIMENSIONS IN MILLIMETERS (INCHES).

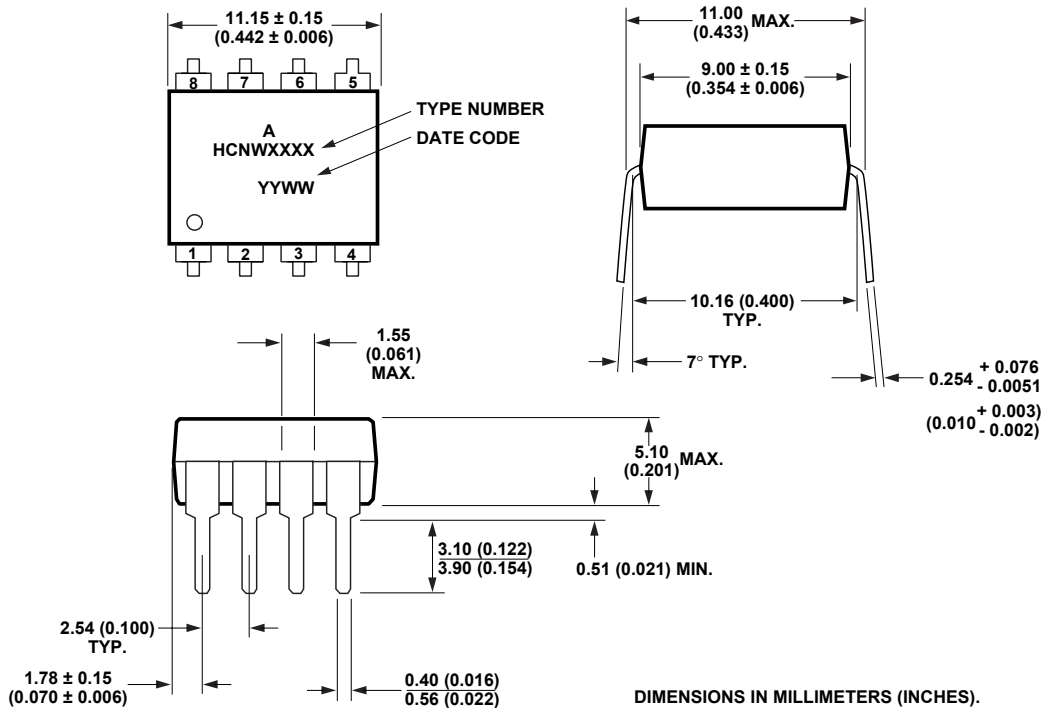
LEAD COPLANARITY = 0.10 mm (0.004 INCHES).

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

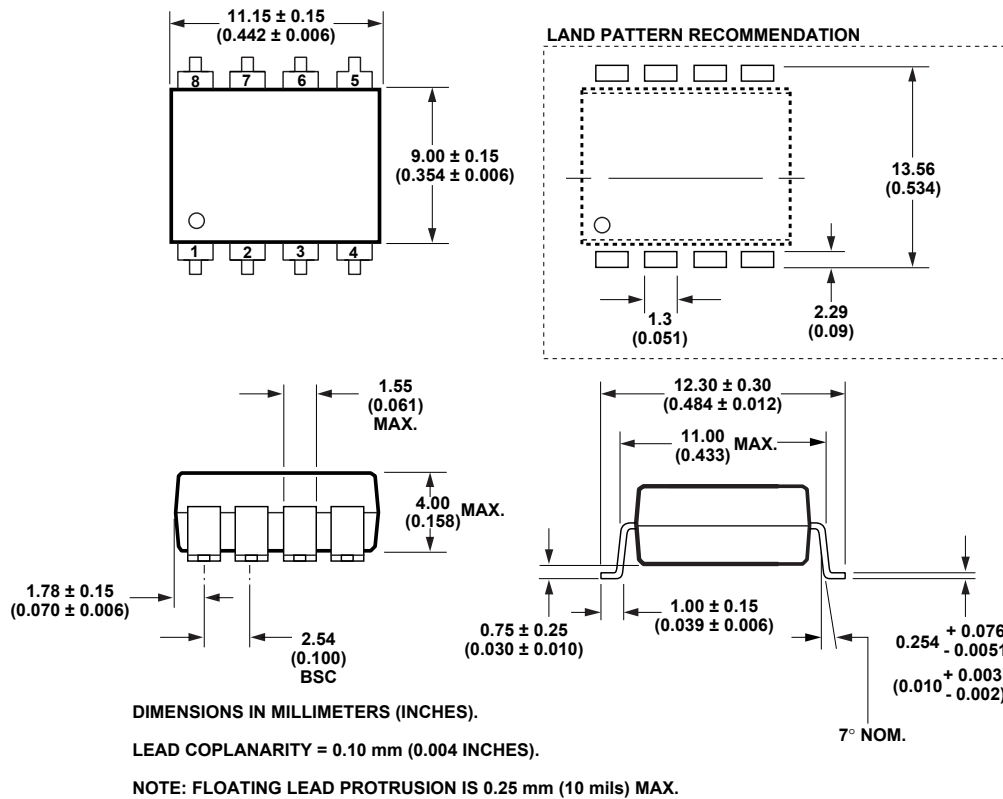
Small Outline SO-8 Package (HCPL-0500/1, HCPL-0452/3)



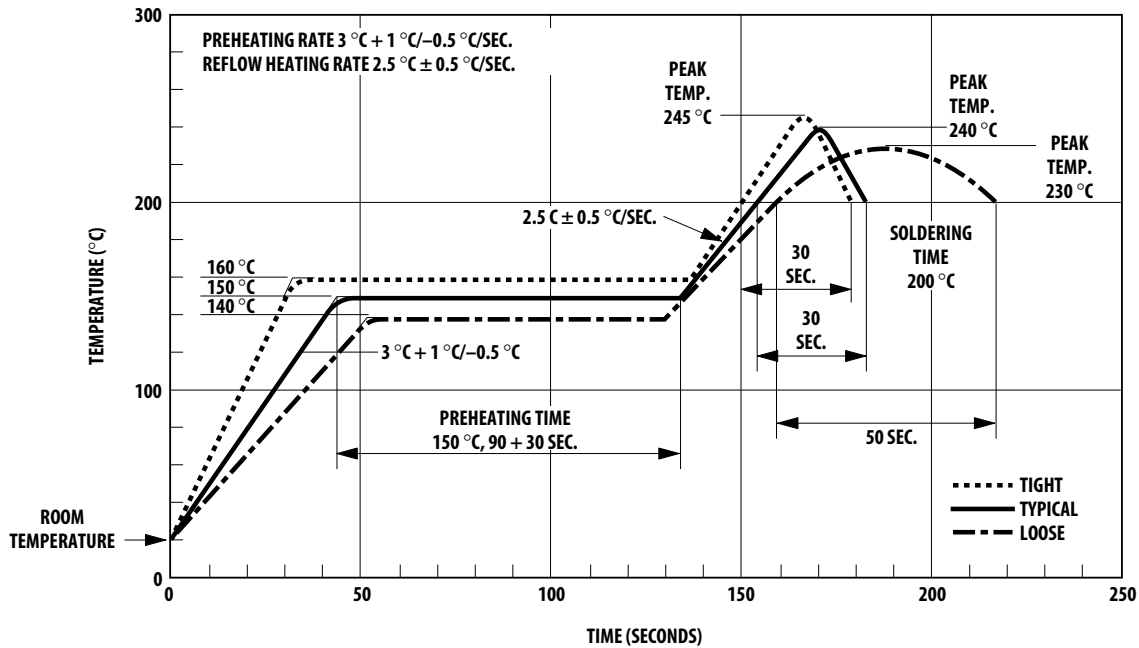
8-Pin Widebody DIP Package (HCNW135/6, HCNW4502/3)



8-Pin Widebody DIP Package with Gull Wing Surface Mount Option 300 (HCNW135/6, HCNW4502/3)

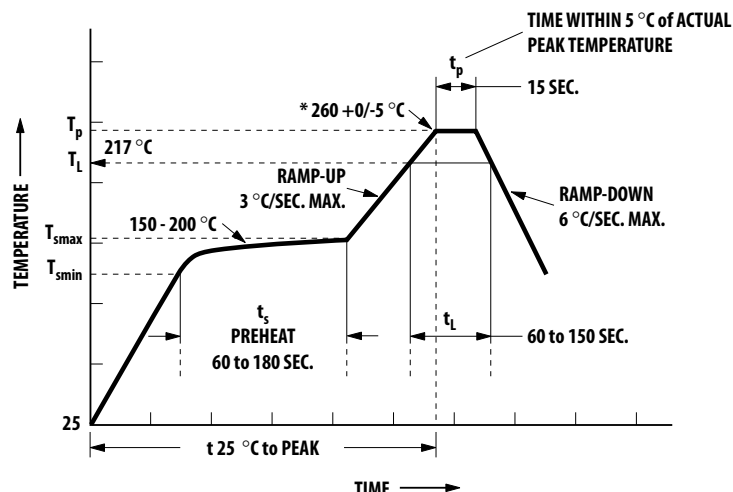


Solder Reflow Temperature Profile



NOTE: NON-HALIDE FLUX SHOULD BE USED.

Recommended Pb-Free IR Profile



NOTES:
THE TIME FROM 25 °C to PEAK TEMPERATURE = 8 MINUTES MAX.
 $T_{smax} = 200\text{ °C}$, $T_{smin} = 150\text{ °C}$

NON-HALIDE FLUX SHOULD BE USED.

* RECOMMENDED PEAK TEMPERATURE FOR WIDEbody 400mils PACKAGE IS 245 °C

Regulatory Information

The devices contained in this data sheet have been approved by the following organizations:

UL

Recognized under UL 1577, Component Recognition Program, File E55361.

CSA

Approved under CSA Component Acceptance Notice #5, File CA 88324.

IEC/EN/DIN EN 60747-5-2

Approved under:
IEC 60747-5-2:1997 + A1:2002
EN 60747-5-2:2001 + A1:2002
DIN EN 60747-5-2 (VDE 0884 Teil 2):2003-01 (HCNW and Option 060 only)

Insulation and Safety Related Specifications

Parameter	Symbol	8-Pin DIP (300 Mil) Value	SO-8 Value	Widebody (400 Mil) Value	Units	Conditions
Minimum External Air Gap (External Clearance)	L(101)	7.1	4.9	9.6	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (External Creepage)	L(102)	7.4	4.8	10.0	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	0.08	1.0	mm	Through insulation distance, conductor to conductor, usually the direct distance between the photoemitter and photodetector inside the optocoupler cavity.
Minimum Internal Tracking (Internal Creepage)		NA	NA	4.0	mm	Measured from input terminals to output terminals, along internal cavity.
Tracking Resistance (Comparative Tracking Index)	CTI	200	200	200	Volts	DIN IEC 112/VDE 0303 Part 1
Isolation Group		IIla	IIla	IIla		Material Group (DIN VDE 0110, 1/89, Table 1)

Option 300 - surface mount classification is Class A in accordance with CECC 00802.

IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics (HCPL-4503 OPTION 060 ONLY)

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1		I-IV	
for rated mains voltage ≤ 300 V rms		I-III	
for rated mains voltage ≤ 450 V rms			
Climatic Classification		55/100/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	630	V _{peak}
Input to Output Test Voltage, Method b*			
$V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	1181	V _{peak}
Input to Output Test Voltage, Method a*			
$V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	945	V _{peak}
Highest Allowable Overvoltage*			
(Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	6000	V _{peak}
Safety Limiting Values			
(Maximum values allowed in the event of a failure, also see Figure 9, Thermal Derating curve.)			
Case Temperature	T_s	175	°C
Input Current	$I_{S,INPUT}$	230	mA
Output Power	$P_{S,OUTPUT}$	600	mW
Insulation Resistance at T_s , $V_{IO} = 500$ V	R_s	$\geq 10^9$	Ω

IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics (HCNW135/6, HCNW4502/3 ONLY)

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1		I-IV	
for rated mains voltage ≤ 600 V rms		I-III	
for rated mains voltage ≤ 1000 V rms			
Climatic Classification		55/85/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	1414	V _{peak}
Input to Output Test Voltage, Method b*			
$V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	2652	V _{peak}
Input to Output Test Voltage, Method a*			
$V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	2121	V _{peak}
Highest Allowable Overvoltage*			
(Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	8000	V _{peak}
Safety Limiting Values			
(Maximum values allowed in the event of a failure, also see Figure 9, Thermal Derating curve.)			
Case Temperature	T_s	150	°C
Input Current	$I_{S,INPUT}$	400	mA
Output Power	$P_{S,OUTPUT}$	700	mW
Insulation Resistance at T_s , $V_{IO} = 500$ V	R_s	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section IEC/EN/DIN EN 60747-5-2, for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

Absolute Maximum Ratings

Parameter	Symbol	Device	Min.	Max.	Units	Note
Storage Temperature*	T_S		-55	125	°C	
Operating Temperature*	T_A	8-Pin DIP SO-8	-55	100	°C	
		Widebody	-55	85		
Average Forward Input Current*	$I_{F(AVG)}$			25	mA	1
Peak Forward Input Current* (50% duty cycle, 1 ms pulse width)	$I_{F(PEAK)}$	8-Pin DIP SO-8		50	mA	2
		Widebody		40		
Peak Transient Input Current* (≤1 μs pulse width, 300 pps)	$I_{F(TRANS)}$	8-Pin DIP SO-8		1	A	
		Widebody		0.1		
Reverse LED Input Voltage* (Pin 3-2)	V_R	8-Pin DIP SO-8		5	V	
		Widebody		3		
Input Power Dissipation*	P_{IN}	8-Pin DIP SO-8		45	mW	3
		Widebody		40		
Average Output Current* (Pin 6)	$I_{O(AVG)}$			8	mA	
Peak Output Current*	$I_{O(PEAK)}$			16	mA	
Emitter-Base Reverse Voltage* (Pin 5-7, except 4502/3, 0452/3)	V_{EBR}			5	V	
Supply Voltage (Pin 8-5)	V_{CC}		-0.5	30	V	
Output Voltage (Pin 6-5)	V_O		-0.5	20	V	
Supply Voltage* (Pin 8-5)	V_{CC}		-0.5	15	V	
Output Voltage* (Pin 6-5)	V_O		-0.5	15	V	
Base Current* (Pin 7, except 4502/3, 0452/3)	I_B			5	mA	
Output Power Dissipation*	P_O			100	mW	4
Lead Solder Temperature* (Through-Hole Parts Only)						
1.6 mm below seating plane, 10 seconds	T_{LS}	8-Pin DIP		260	°C	
up to seating plane, 10 seconds		Widebody		260	°C	
Reflow Temperature Profile	T_{RP}	SO-8 and Option 300	See Package Outline Drawings section			

*Data has been registered with JEDEC for the 6N135/6N136.

Electrical Specifications (DC)

Over recommended temperature ($T_A = 0^\circ\text{C}$ to 70°C) unless otherwise specified. See note 13.

Parameter	Symbol	Device	Min.	Typ.**	Max.	Units	Test Conditions			Fig.	Note			
Current Transfer Ratio	CTR*	6N135	7	18	50	%	T _A = 25°C	V _O = 0.4 V	I _F = 16 mA, V _{CC} = 4.5 V	1, 2, 4	5, 11			
		HCPL-0500 HCNW135	5	19				V _O = 0.5 V						
		HCPL-2502	15		22		T _A = 25°C	V _O = 0.4 V						
			15	25				V _O = 0.5 V						
		6N136	19	24	50		T _A = 25°C	V _O = 0.4 V						
		HCPL-4502/3 HCPL-0501	15	25				V _O = 0.5 V						
		HCPL-0452/3 HCNW136 HCNW4502/3												
Logic Low Output Voltage	V _{OL}	6N135		0.1	0.4		V	T _A = 25°C	I _O = 1.1 mA			I _F = 16 mA, V _{CC} = 4.5 V		
		HCPL-0500 HCNW135		0.1	0.5			I _O = 0.8 mA						
		6N136		0.1	0.4	T _A = 25°C		I _O = 3.0 mA						
		HCPL-2502		0.1	0.5			I _O = 2.4 mA						
		HCPL-4502/3 HCPL-0501												
		HCPL-0452/3 HCNW136 HCNW4502/3												
Logic High Output Current	I _{OH} *			0.003	0.5	μA		T _A = 25°C	V _O = V _{CC} = 5.5 V	I _F = 0 mA	7			
				0.01	1			T _A = 25°C	V _O = V _{CC} = 15 V					
					50			V _O = V _{CC} = 15 V						
Logic Low Supply Current	I _{CCL}			50	200	μA	I _F = 16 mA, V _O = Open, V _{CC} = 15 V			13				
Logic High Supply Current	I _{CCH} *			0.02	1	μA	T _A = 25°C	I _F = 16 mA, V _O = Open, V _{CC} = 15 V		13				
					2									
Input Forward Voltage	V _F *	8-Pin DIP		1.5	1.7	V	T _A = 25°C	I _F = 16 mA		3				
		SO-8			1.8									
		Widebody	1.45	1.68	1.85		T _A = 25°C	I _F = 16 mA						
			1.35		1.95									
Input Reverse Breakdown Voltage	BV _R *	8-Pin DIP	5			V	I _R = 10 μA							
		SO-8												
		Widebody	3				I _R = 100 μA							
Temperature Coefficient of Forward Voltage	ΔV _F /ΔT _A	8-Pin DIP		-1.6		mV/°C	I _F = 16 mA							
		SO-8												
		Widebody		-1.9										
Input Capacitance	C _{IN}	8-Pin DIP		60		pF	f = 1 MHz, V _F = 0 V							
		SO-8												
		Widebody		90										
Transistor DC Current Gain	h _{FE}	8-Pin DIP		150			V _O = 5 V, I _O = 3 mA							
		SO-8		130			V _O = 0.4 V, I _B = 20 μA							
		Widebody		180			V _O = 0.4 V, I _B = 20 μA							
				160			V _O = 5 V, I _O = 3 mA							

*For JEDEC registered parts.

**All typicals at $T_A = 25^\circ\text{C}$.

Switching Specifications (AC)

Over recommended temperature ($T_A = 0^\circ\text{C}$ to 70°C), $V_{CC} = 5\text{ V}$, $I_F = 16\text{ mA}$ unless otherwise specified.

Parameter	Sym.	Device	Min.	Typ.**	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to Logic Low at Output	t_{PHL}^*	6N135		0.2	1.5	μs	$T_A = 25^\circ\text{C}$ $R_L = 4.1\text{ k}\Omega$	5, 6, 11	8, 9
		HCPL-0500			2.0				
		HCNW135							
		6N136		0.2	0.8		$T_A = 25^\circ\text{C}$ $R_L = 1.9\text{ k}\Omega$		
		HCPL-2502							
		HCPL-4502/3							
		HCPL-0501							
		HCPL-0452/3			1.0				
Propagation Delay Time to Logic High at Output	t_{PLH}^*	6N135		1.3	1.5	μs	$T_A = 25^\circ\text{C}$ $R_L = 4.1\text{ k}\Omega$	5, 6, 11	8, 9
		HCPL-0500			2.0				
		HCNW135							
		6N136		0.6	0.8		$T_A = 25^\circ\text{C}$ $R_L = 1.9\text{ k}\Omega$		
		HCPL-2502							
		HCPL-4502/3							
		HCPL-0501							
		HCPL-0452/3			1.0				
Common Mode Transient Immunity at Logic High Level Output	$ CM_H $	6N135	1			$\text{kV}/\mu\text{s}$	$R_L = 4.1\text{ k}\Omega$ $I_F = 0\text{ mA}$, $T_A = 25^\circ\text{C}$, $V_{CM} = 10\text{ V}_{\text{p-p}}$ $C_L = 15\text{ pF}$	12	7, 8, 9
		HCPL-0500		1					
		HCNW135							
		6N136	1				$R_L = 1.9\text{ k}\Omega$		
		HCPL-2502		1					
		HCPL-4502							
		HCPL-0501							
		HCPL-0452							
		HCNW4502							
		HCPL-4503	15	30			$R_L = 1.9\text{ k}\Omega$ $I_F = 0\text{ mA}$, $T_A = 25^\circ\text{C}$, $V_{CM} = 1500\text{ V}_{\text{p-p}}$ $C_L = 15\text{ pF}$		
Common Mode Transient Immunity at Logic Low Level Output	$ CM_L $	6N135	1			$\text{kV}/\mu\text{s}$	$R_L = 4.1\text{ k}\Omega$ $I_F = 16\text{ mA}$, $T_A = 25^\circ\text{C}$, $V_{CM} = 10\text{ V}_{\text{p-p}}$ $C_L = 15\text{ pF}$	12	7, 8, 9
		HCPL-0500		1					
		HCNW135							
		6N136	1				$R_L = 1.9\text{ k}\Omega$		
		HCPL-2502		1					
		HCPL-4502							
		HCPL-0501							
		HCPL-0452							
		HCNW4502							
		HCPL-4503	15	30			$R_L = 1.9\text{ k}\Omega$ $I_F = 16\text{ mA}$, $T_A = 25^\circ\text{C}$, $V_{CM} = 1500\text{ V}_{\text{p-p}}$ $C_L = 15\text{ pF}$		
Bandwidth	BW	6N135/6		9		MHz	See Test Circuit	8, 10	10
		HCPL-2502							
		HCPL-0500/1							
		HCNW135/6		11					

*For JEDEC registered parts.

**All typicals at $T_A = 25^\circ\text{C}$.

Package Characteristics

Over recommended temperature ($T_A = 0^\circ\text{C}$ to 70°C) unless otherwise specified.

Parameter	Sym.	Device	Min.	Typ.*	Max.	Units	Test Conditions	Fig.	Note
Input-Output Momentary Withstand Voltage**	V_{ISO}	8-Pin DIP	3750			V rms	RH < 50%, t = 1 min., $T_A = 25^\circ\text{C}$		6, 14
		SO-8							6, 15
		Widebody	5000						
		8-Pin DIP (Option 020)	5000						6, 12, 15
	I_{I-O}	8-Pin DIP			1	μA	45% RH, t = 5 s, $V_{I-O} = 3 \text{ kVdc}$, $T_A = 25^\circ\text{C}$		6, 16
Input-Output Resistance	R_{I-O}	8-Pin DIP		10^{12}		Ω	$V_{I-O} = 500 \text{ Vdc}$		6
		SO-8							
		Widebody	10^{12}	10^{13}			$T_A = 25^\circ\text{C}$		
			10^{11}				$T_A = 100^\circ\text{C}$		
Input-Output Capacitance	C_{I-O}	8-Pin DIP		0.6		pF	f = 1 MHz		6
		SO-8							
		Widebody		0.5	0.6				

*All typicals at $T_A = 25^\circ\text{C}$.

**The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics Table (if applicable), your equipment level safety specification or Avago Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage," publication number 5963-2203E.

Notes:

- Derate linearly above 70°C free-air temperature at a rate of $0.8 \text{ mA}/^\circ\text{C}$ (8-Pin DIP).
Derate linearly above 85°C free-air temperature at a rate of $0.5 \text{ mA}/^\circ\text{C}$ (SO-8).
- Derate linearly above 70°C free-air temperature at a rate of $1.6 \text{ mA}/^\circ\text{C}$ (8-Pin DIP).
Derate linearly above 85°C free-air temperature at a rate of $1.0 \text{ mA}/^\circ\text{C}$ (SO-8).
- Derate linearly above 70°C free-air temperature at a rate of $0.9 \text{ mW}/^\circ\text{C}$ (8-Pin DIP).
Derate linearly above 85°C free-air temperature at a rate of $1.1 \text{ mW}/^\circ\text{C}$ (SO-8).
- Derate linearly above 70°C free-air temperature at a rate of $2.0 \text{ mW}/^\circ\text{C}$ (8-Pin DIP).
Derate linearly above 85°C free-air temperature at a rate of $2.3 \text{ mW}/^\circ\text{C}$ (SO-8).
- CURRENT TRANSFER RATIO in percent is defined as the ratio of output collector current, $I_{O'}$ to the forward LED input current, I_F times 100.
- Device considered a two-terminal device: Pins 1, 2, 3, and 4 shorted together and Pins 5, 6, 7, and 8 shorted together.
- Common mode transient immunity in a Logic High level is the maximum tolerable (positive) dV_{CM}/dt on the leading edge of the common mode pulse signal, $V_{CM'}$ to assure that the output will remain in a Logic High state (i.e., $V_O > 2.0 \text{ V}$). Common mode transient immunity in a Logic Low level is the maximum tolerable (negative) dV_{CM}/dt on the trailing edge of the common mode pulse signal, $V_{CM'}$ to assure that the output will remain in a Logic Low state (i.e., $V_O < 0.8 \text{ V}$).
- The $1.9 \text{ k}\Omega$ load represents 1 TTL unit load of 1.6 mA and the $5.6 \text{ k}\Omega$ pull-up resistor.
- The $4.1 \text{ k}\Omega$ load represents 1 LSTTL unit load of 0.36 mA and $6.1 \text{ k}\Omega$ pull-up resistor.
- The frequency at which the ac output voltage is 3 dB below its mid-frequency value.
- The JEDEC registration for the 6N136 specifies a minimum CTR of 15%. Avago guarantees a minimum CTR of 19%.
- See Option 020 data sheet for more information.
- Use of a $0.1 \mu\text{F}$ bypass capacitor connected between pins 5 and 8 is recommended.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 4500 \text{ V rms}$ for 1 second (leakage detection current limit, $I_{I-O} \leq 5 \mu\text{A}$). This test is performed before the 100% Production test shown in the IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics Table if applicable.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 6000 \text{ V rms}$ for 1 second (leakage detection current limit, $I_{I-O} \leq 5 \mu\text{A}$). This test is performed before the 100% Production test shown in the IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics Table if applicable.
- This rating is equally validated by an equivalent ac proof test.

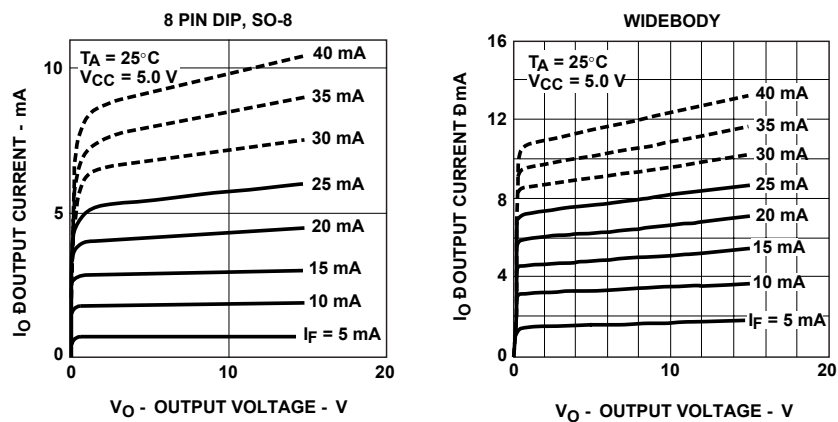


Figure 1. DC and pulsed transfer characteristics.

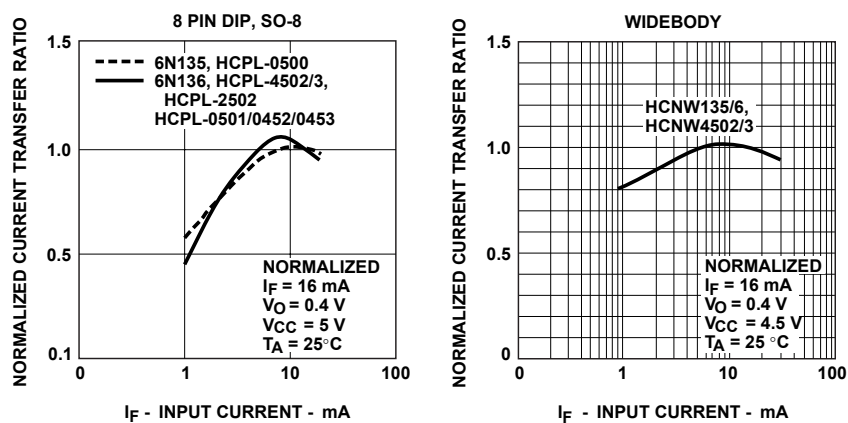


Figure 2. Current transfer ratio vs. input current.

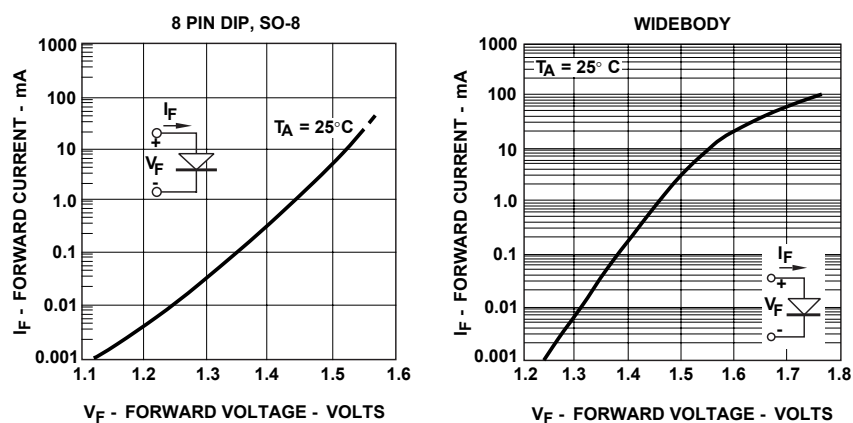


Figure 3. Input current vs. forward voltage.

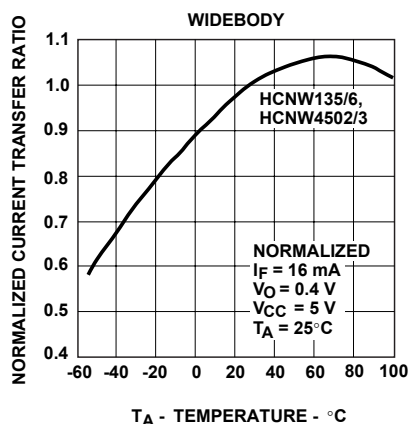
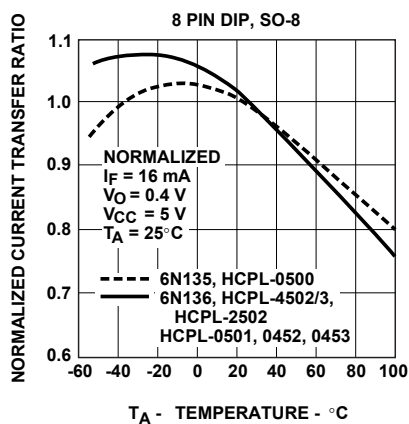


Figure 4. Current transfer ratio vs. temperature.

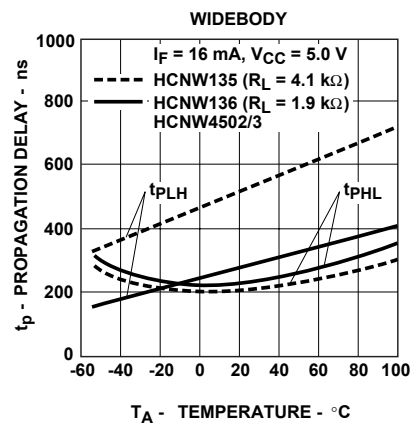
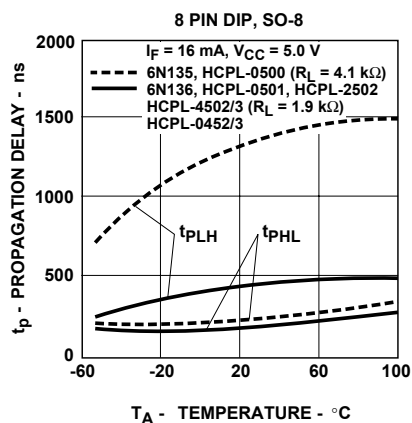


Figure 5. Propagation delay vs. temperature.

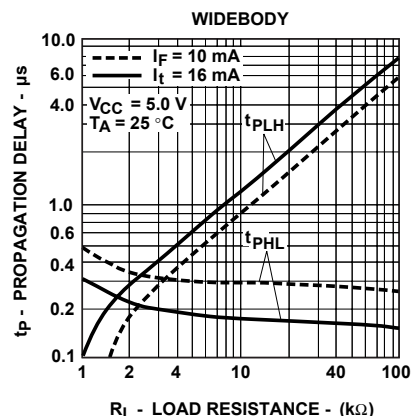
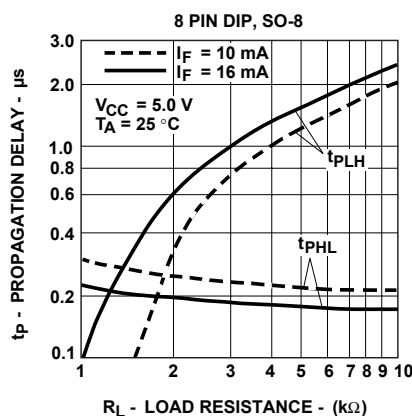


Figure 6. Propagation delay time vs. load resistance.

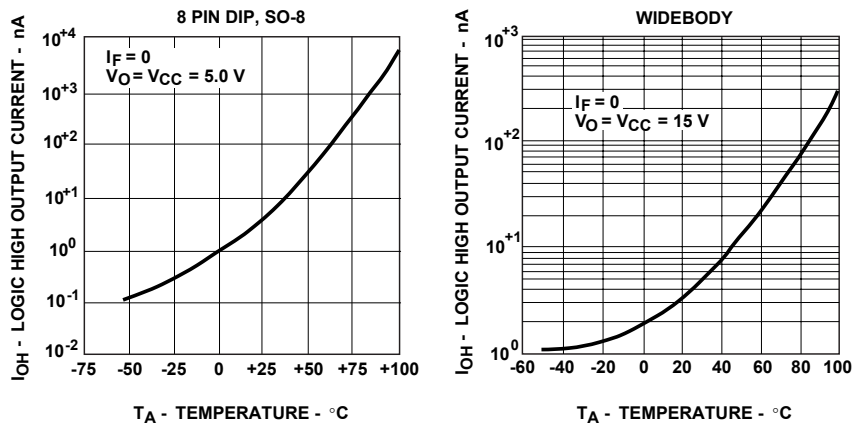


Figure 7. Logic high output current vs. temperature.

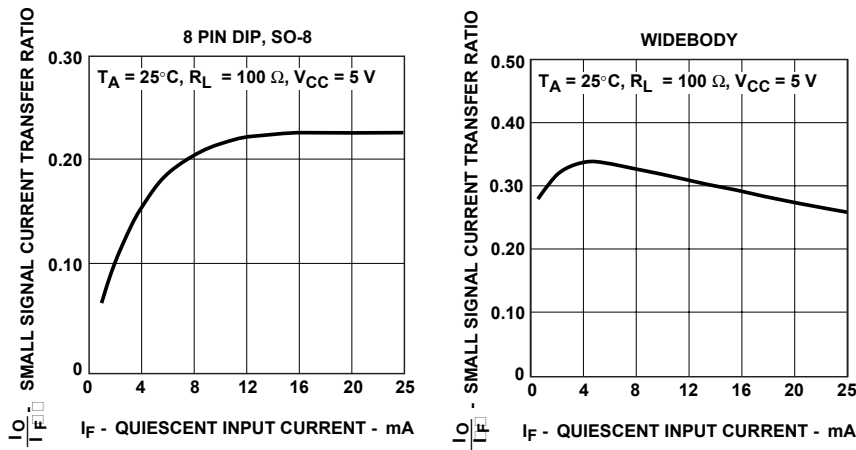


Figure 8. Small-signal current transfer ratio vs. quiescent input current.

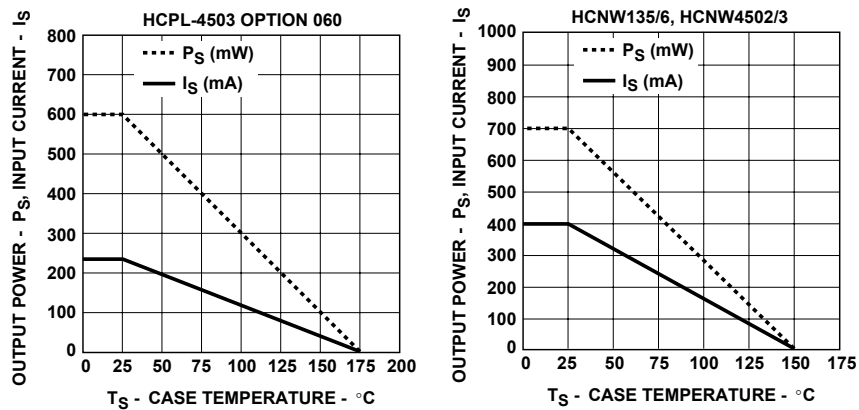


Figure 9. Thermal derating curve, dependence of safety limiting value with case temperature per IEC/EN/DIN EN 60747-5-2.

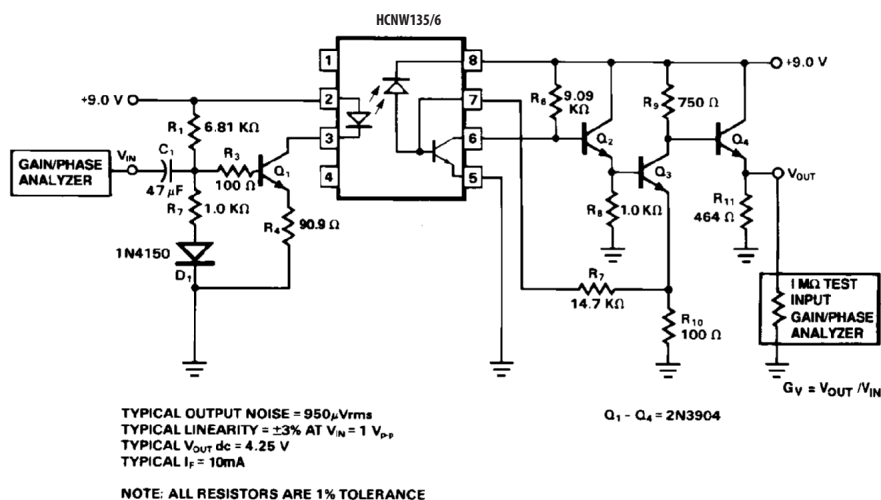
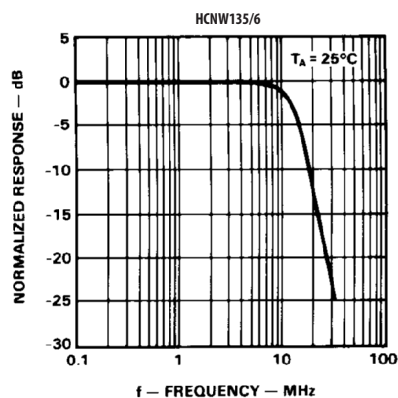
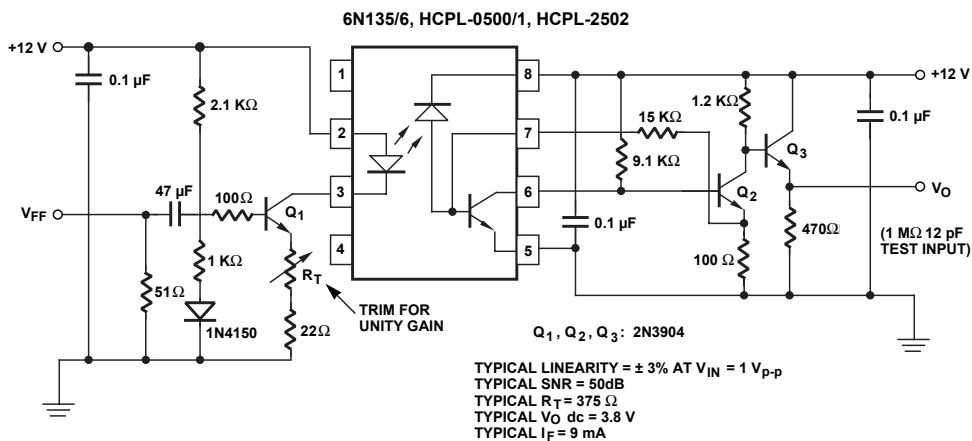
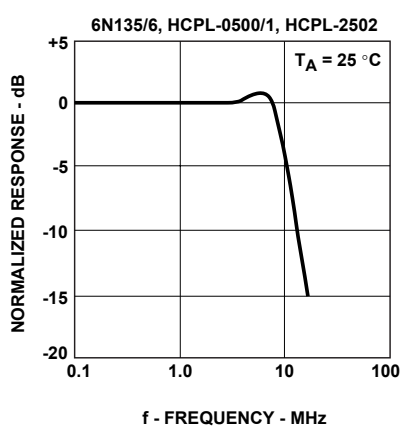


Figure 10. Frequency response.



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